## Wideband Monolithic Amplifier Die

50Ω 0.5 to 18 GHz

#### **The Big Deal**

- Super Wideband, 0.5 to 18 GHz
- Excellent Gain Flatness(±1.6 dB up to 18 GHz)
- Good Directivity, 18 dB typ.



#### **Product Overview**

The LTA-5R183-D+ is a super wideband amplifier amplifier die that operates over 0.5 to 18 GHz fabricated using PHEMT process. It delivers excellent gain flatness, good return loss, medium current with good P1dB and OIP3 across a wide bandwidth without the need of external matching network.

#### **Key Features**

Feature	Advantages
Super Wideband: 0.5 to 18 GHz	General purpose wideband amplifier is suitable for various applications including HF, VHF thru KU band.
Excellent gain flatness ± 1.6 dB up to 18 GHz	As a desirable characteristic of a wideband amplifier, excellent gain flatness allows amplification of a signal without changing the waveform in time domain.
Good Directivity, 18 dB typ.	Isolates adjacent circuitry without need for an external expensive isolator.
Good input and output return loss	Eliminates need for external matching circuit providing published return loss.
Unpackaged Die	Enables the user to integrate the amplifier directly into hybrids

## Wideband Monolithic Amplifier Die

### LTA-5R183-D+

#### 50Ω 0.5 to 18 GHz

#### **Product Features**

- Super Wideband, 0.5 to 18 GHz
- Excellent Gain Flatness, ±1.6 dB up to 18 GHz
- Good directivity, 18 dB typ.

#### **Typical Applications**

- Instrumentation
- Cellular Infrastructure
- Defense

# EL-AMP-5-2

+RoHS Compliant The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

#### **General Description**

The LTA-5R183-D+ is a super wideband amplifier amplifier die that operates over 0.5 to 18 GHz fabricated using PHEMT process. It delivers excellent gain flatness, good return loss, medium current with good P1dB and OIP3 across a wide bandwidth without the need of external matching network.

#### Simplified Schematic and Pad description



Pad #	Description
1	RF-IN
4	RF-OUT & VDD
6	VG
2,3,5,7 & Bottom of die	GROUND

**Bonding Pad Position** 



			Dii	nension	is in µm	, Typic	al			
L1	L2	L3	L4	H1	H2	H3	H4	H5	H6	H7
96	2351	2518	2614	99	267	417	1024	1172	1324	1438

Thickness	Die size	Pad Size 1,4 & 6	Pad size 2,3,5,7
100	2614 x 1438	100 x 100	85 x 85

REV. A ECO-00004323 LTA-5R183-D+ GY/RS/CP 201001 Page 2 of 6



Parameter	Condition		V <sub>DD</sub> =5V <sup>1</sup>		Units
	(MHz)	Min.	Тур.	Max.	
Frequency range <sup>1</sup>		0.5		18	GHz
Gain	500		14.6		dB
	5000		12.9		
	10000		13.3		
	15000		12.5		
	18000		13.1		
Input return loss	500		12		dB
	5000		12		
	10000		13		
	15000		9		
	18000		12		
Output return loss	500		36		dB
	5000		25		
	10000		34		
	15000		16		
	18000		17		
Reverse isolation	10000		38.4		dB
Output power @1dB compression	500		19.5		dBm
	5000		19.7		
	10000		18.6		
	15000		17.7		
	18000		16.3		
Output IP3 <sup>2</sup>	500		31.3		dBm
	5000		27.4		
	10000		23.3		
	15000		21.7		
	18000		20		
Noise figure	500		4.8		dB
	5000		3.3		
	10000		2.8		
	15000		3.6		
	18000		4.4		
Device Operating Voltage (V <sub>DD</sub> )		4.75	5	5.25	V
Device Operating Current(I <sub>DD</sub> )			85		mA
Device Gate Voltage(V <sub>G</sub> )			-0.94		V
Device Gate Current (I <sub>G</sub> )			0.47		μA
Device Current Variation vs. Temperature <sup>3</sup>			264.5		μA/°C
Device Current Variation vs. Voltage <sup>4</sup>			0.007		mA/mV
Thermal Resistance, Junction-to-ground lead at 85°C stage temperature			22.2		°C/W

#### Electrical Specifications at 25°C, V\_{DD}=5V, I\_{DD}=85mA & Zo=50 \Omega unless noted

1. Die is tested in die characterization board. See characterization circuit (Fig. 1)

2. Tested at Pout=0dBm / tone.

Current variation over temperature=(Current at 100°C — Current at -55°C)/155°C
Current variation over voltage=(Current at 5.25V-current - Current at 4.75V)/1000

#### Absolute Maximum Ratings<sup>5</sup>

Parameter	Ratings
Operating Temperature (ground lead)	-55°C to 100°C
Junction Temperature	150°C
Power Dissipation	4.4W <sup>6</sup>
Input Power (CW)	+22 dBm
DC voltage on RF-OUT & V <sub>DD</sub>	7V
DC voltage on V <sub>G</sub>	-0.5V to -2V
DC voltage on RF-IN7	7V
Current I <sub>DD</sub>	250mA
Current I <sub>G</sub>	2mA

Permanent damage may occur in any of these limits are exceeded. Electrical maximum ratings are not intended for continuous normal operation.
Derates linearly 1.57W at 100°C.

7. DC signal at RF-IN will be blocked by internal blocking capacitor. However, a DC current of  $3.5\mu$ A will be present due to the input shunt resistor assuming V<sub>RF-IN</sub>=7V.



#### **Characterization Test Circuit**



Component	Size	Value	Part Number	Manufacturer
R1	0402	1K Ohm	FC0402E1001DTT5	Vishary
C1	0402	100pF	GRM1555C1H101JA01J	Murata
C2	0402	0.1uF	GRM155R71C104KA88D	Murata
C3	Chip Capacitor	100pF	MA4M3100	MACOM

Fig 1. Characterization Circuit

Note: This block diagram is used for characterization. (Die is attached and wire-bonded on die characterization test board. Gain, Return loss, Output power at 1dB compression (P1dB), output IP3 (OIP3) and noise figure are measured using Agilent's N5242A PNA- X microwave network analyzer.

Conditions:

1. V<sub>DD</sub>=5V

- 2. VG is set to obtain desired IDD as shown in specification table.
- 3. Gain and Return loss: Pin= -25dBm
- 4. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 0 dBm/tone at output.

Switch ON/OFF sequence:

- 1. To switch the amplifier ON:

  - a. Turn on V<sub>G</sub> with V<sub>G</sub>=-1.1V b. Turn on V<sub>DD</sub> with V<sub>DD</sub>=5V c. Increase V<sub>G</sub> to obtain desired I<sub>DD</sub> as shown in specification table. d. Apply RF signal

2. To switch the amplifier OFF:

- a. Turn OFF RF signal
- b. Turn OFF V<sub>DD</sub>
- c. Turn OFF  $V_{G}^{J}$



#### **Assembly Diagram**



#### **Assembly and Handling Procedure**

1. Storage

Dice should be stored in a dry nitrogen purged desiccators or equivalent.

2. ESD

MMIC PHEMT amplifier dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be open in clean room conditions at an appropriately grounded anti-static workstation.

3. Die Handling and Attachment

Devices need careful handling using correctly designed collets, it is recommended to handle the chip along the edges with a custom design collet. The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epox ies are DieMat DM6030HK-PT/H579 or Ablestik 84-1 LMISR4 or equivalents. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. The surface of the chip has exposed air bridges and should not be touched with vacuum col let, tweezers or fingers.

4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermo-sonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1mil diameter. Bonds must be made from the bond pads on the die to the packaged or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.



Additional Detailed Technical additional information is available on our da	Information sh board.			
	Data Table			
Performance Data	Swept Graphs			
	S-Parameter (S2P Files) Data Set with and without port extension(.zip file)			
Case Style	Die			
	Quantity, Package	Model No.		
	Small, Gel - Pak: 5,10,50,100 KGD*	LTA-5R183-DG+		
Die Ordering and packaging	Large <sup>†</sup> , Full Wafer	LTA-5R183-DP+ LTA-5R183-DF+		
Information	<sup>†</sup> Available upon request contact sales representative			
	Refer to <u>AN-60-067</u>			
Environmental Ratings	ENV80			

\*Known Good Dice ("KGD") means that the dice are taken from PCM good wafer and visually inspected in question have been subjected to Mini-Circuits while this is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

#### **ESD Rating\*\***

Human Body Model (HBM): Class 1A (pass 250V) in accordance with ANSI/ESD STM 5.1 - 2001

\*\* Tested in 4.24x4.24mm, 10 Lead, LTCC package

#### **Additional Notes**

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
- C. The parts covered by this specification document are subject to Mini-Circuits standard limited warranty and terms and conditions (collectively, "Standard Terms"); Purchasers of this part are entitled to the rights and benefits contained therein. For a full statement of the Standard Terms and the exclusive rights and remedies thereunder, please visit Mini-Circuits' website at www.minicircuits.com/MCLStore/terms.jsp
- D. Mini-Circuits does not warrant the accuracy or completeness of the information, text, graphics and other items contained within this document and same are provided as an accommodation and on an "As is" basis, with all faults.
- E. Purchasers of this part are solely responsible for proper storing, handling, assembly and processing of Known Good Dice (including, without limitation, proper ESD preventative measures, die preparation, die attach, wire bond ing and related assembly and test activities), and Mini-Circuits assumes no responsibility therefor or for environmental effects on Known Good Dice.
- F. Mini-Circuits and the Mini-Circuits logo are registered trademarks of Scientific Components Corporation d/b/a Mini-Circuits. All other third-party trademarks are the property of their respective owners. A reference to any third-party trademark does not constitute or imply any endorsement, affiliation, sponsorship, or recommendation by any such third-party of Mini-Circuits or its products.